

Absolute Maximum Ratings		Values	Units
Symbol	Conditions <sup>1)</sup>		
$V_{DS}$		200	V
$V_{DGR}$	$R_{GS} = 20 \text{ k}\Omega$	200	V
$I_D$	$T_{case} = 25^\circ\text{C}$	120	A
	$T_{case} = 85^\circ\text{C}$	87	A
$I_{DM}$		360	A
$V_{GS}$		$\pm 20$	V
$P_D$		500	W
$T_j, (T_{stg})$		$-40 \dots +150$ (125)	°C
$V_{isol}$	AC, 1 min	2 500	V
humidity climate	DIN 40 040 DIN IEC 68 T.1	Class F 40/125/56	
Inverse Diode			
$I_F = -I_D$		120	A
$I_{FM} = -I_{DM}$		360	A

Characteristics		min.	typ.	max.	Units
Symbol	Conditions <sup>1)</sup>				
$V_{(BR)DSS}$	$V_{GS} = 0, I_D = 0,25 \text{ mA}$	200	—	—	V
$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	2,1	3,0	4,0	V
$I_{DSS}$	$V_{GS} = 0$ $\left. \begin{array}{l} T_j = 25^\circ\text{C} \\ V_{GS} = 200 \text{ V} \end{array} \right\} T_j = 125^\circ\text{C}$	—	50	250	μA
$I_{GSS}$	$V_{GS} = 20 \text{ V}, V_{DS} = 0$	—	300	1000	μA
$R_{DS(on)}$	$V_{GS} = 10 \text{ V}, I_D = 120 \text{ A}$	—	10	100	nA
$g_{fs}$	$V_{GS} = 5 \text{ V}, I_D = 75 \text{ A}$	60	90	—	S
$C_{CHC}$	per MOSFET	—	—	100	pF
$C_{iss}$	$V_{GS} = 0$	—	10,4	16	nF
$C_{oss}$	$V_{DS} = 25 \text{ V}$	—	2	4,5	nF
$C_{rss}$	$f = 1 \text{ MHz}$	—	1	1,4	nF
$L_{DS}$		—	—	30	nH
$t_{d(on)}$	$V_{DD} = 100 \text{ V}$	—	120	—	ns
$t_r$	$I_D = 75 \text{ A}$	—	60	—	ns
$t_{d(off)}$	$V_{GS} = 10 \text{ V}$	—	240	—	ns
$t_f$	$R_{GS} = 3,3 \Omega$	—	40	—	ns
Inverse Diode					
$V_{SD}$	$I_F = 240 \text{ A}, V_{GS} = 0$	—	1,2	1,5	V
$t_{rr}$	$T_j = 25^\circ\text{C}$ <sup>2)</sup>	—	400	—	ns
	$T_j = 150^\circ\text{C}$ <sup>2)</sup>	—	700	—	ns
$Q_{rr}$	$T_j = 25^\circ\text{C}$ <sup>2)</sup>	—	5,0	—	μC
	$T_j = 150^\circ\text{C}$ <sup>2)</sup>	—	8	—	
Thermal Characteristics					
$R_{thjc}$	per MOSFET	—	—	0,25	°C/W
$R_{thch}$	per module	—	—	0,05	°C/W

Mechanical Data		SI Units (M6) US Units	4 35	5 44	Nm lb.in.
M <sub>1</sub>	to heatsink				
M <sub>2</sub>	for terminals	SI Units (M5) US Units	2,5 22	3,5 24	Nm lb.in.
			— —	5x9,81 160	m/s <sup>2</sup> g
a w			— —		
Case	→ page B 5 – 38		D 70		

<sup>1)</sup>  $T_{case} = 25^\circ\text{C}$ , unless otherwise specified.

<sup>2)</sup>  $I_F = -I_D, V_R = 100 \text{ V}, -di_F/dt = 100 \text{ A}/\mu\text{s}$

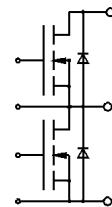
## SEMITRANS® M Power MOSFET Modules 120 A, 200 V, 17 mΩ

### SKM 120 B 020

Replaces discontinued SKM 224 A



### SEMITRANS 2



### Features

- N Channel, enhancement mode
- Short internal connections avoid oscillations
- Isolated copper baseplate using Al<sub>2</sub>O<sub>3</sub> ceramic Direct Copper Bonding Technology (DCB)
- All electrical connections on top for easy busbaring
- Large clearances (10 mm) and creepage distances (20 mm)
- UL recognized, file E63 532

### Typical Applications

- Switched mode power supplies
- DC servo and robot drives
- DC choppers
- UPS equipment
- Plasma cutting
- Not suitable for linear amplification

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

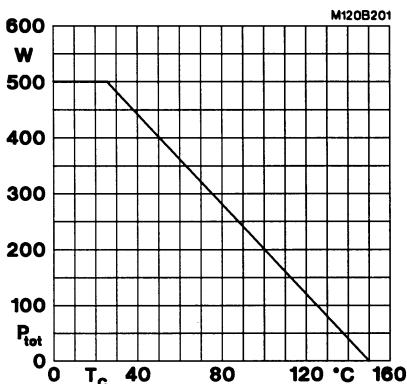


Fig. 1 Rated power dissipation vs. temperature

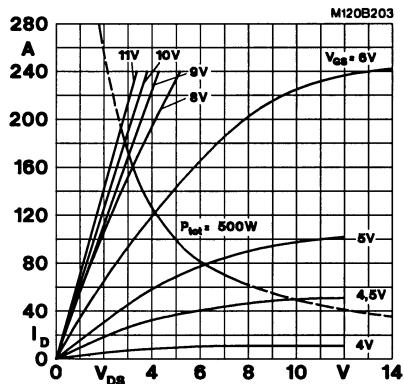


Fig. 3 Output characteristic

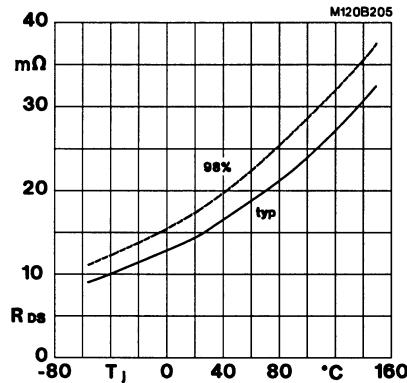


Fig. 5 On-resistance vs. temperature;  $I_D = 120 \text{ A}$ ;  $V_{GS} = 10 \text{ V}$

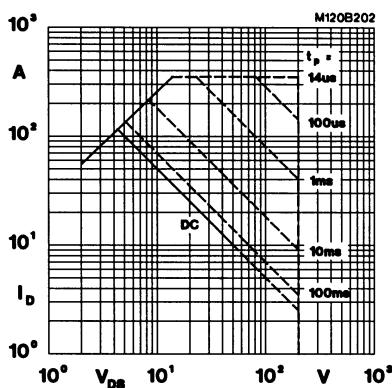


Fig. 2 Maximum safe operating area

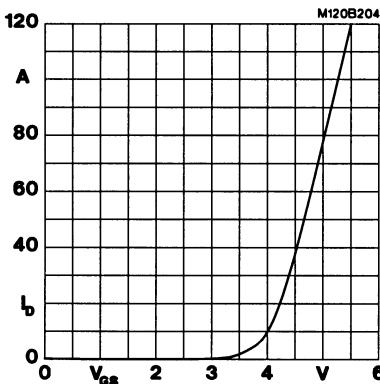


Fig. 4 Transfer characteristic

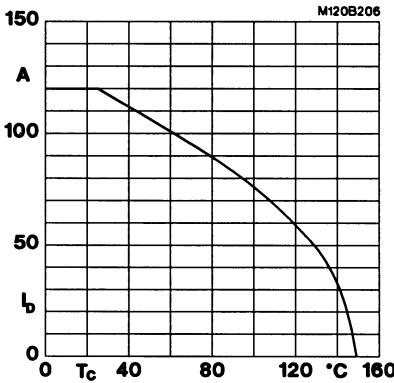


Fig. 6 Rated current vs. temperature;  $V_{GS} = 10 \text{ V}$

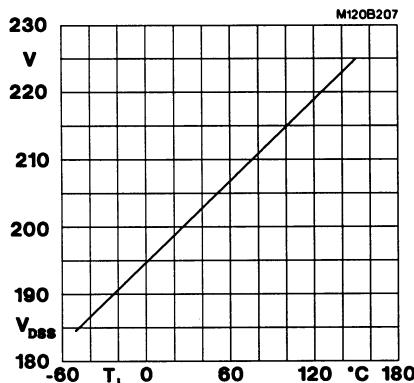


Fig. 7 Breakdown voltage vs. temperature

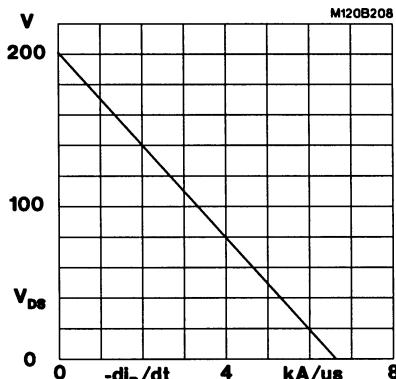


Fig. 8 Drain-source voltage derating

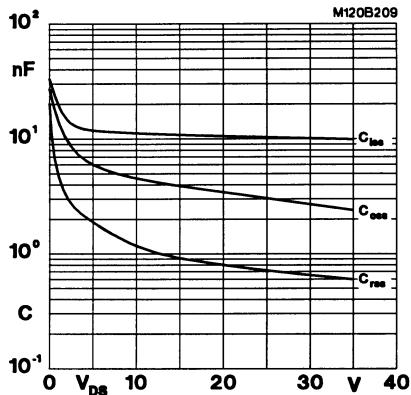


Fig. 9 Capacitances vs. drain-source voltage

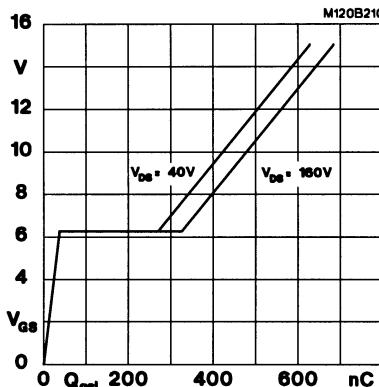


Fig. 10 Gate charge characteristic

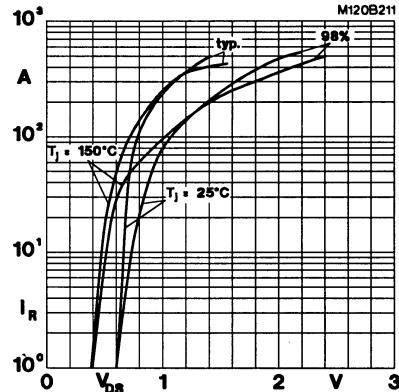


Fig. 11 Diode forward characteristic

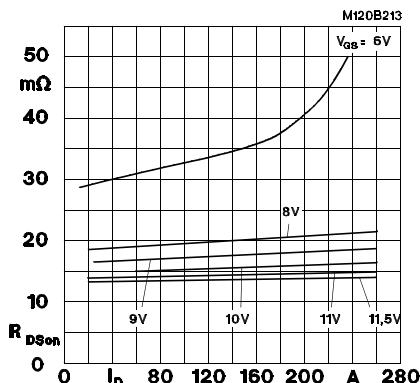


Fig. 13 On-resistance vs. drain current

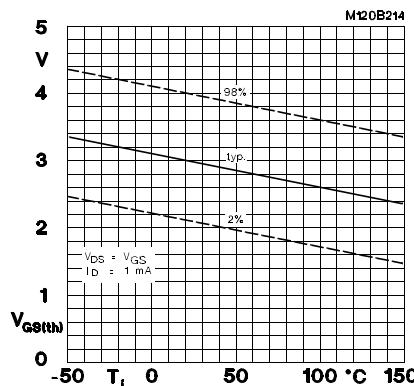


Fig. 14 Gate-source threshold voltage

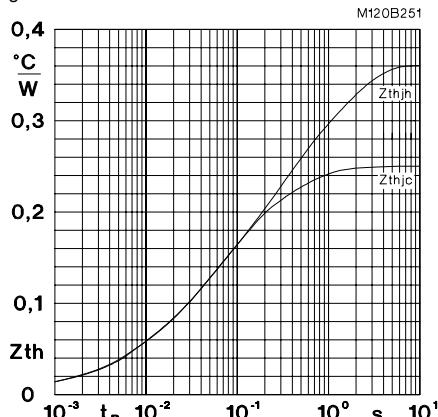


Fig. 51 Transient thermal impedance

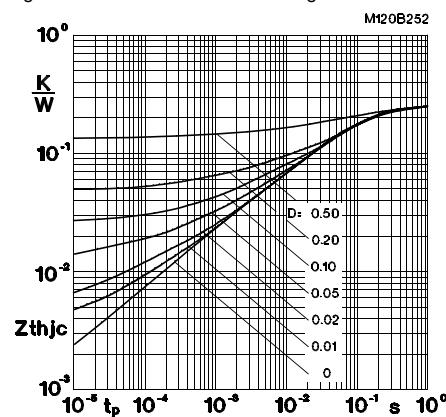
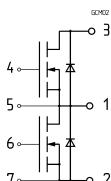


Fig. 52 Thermal impedance under pulse conditions

## SEMITRANS 2

Case D 70



Dimensions in mm

